## Notice of References Cited Application/Control No. 10/616,631 Examiner Alvin H. Tan Applicant(s)/Patent Under Reexamination YAMATO ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,434,447	08-2002	Shteyn, Yevgeniy Eugene	700/245
	В	US-			
	O	US-			
	ם	US-			
	E	US-			
	F	US-			
	G	US-			
	Ξ	US-			
	_	US-			
	7	US-			
	Κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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